

SWITCHING
N-CHANNEL POWER MOS FET
INDUSTRIAL USE

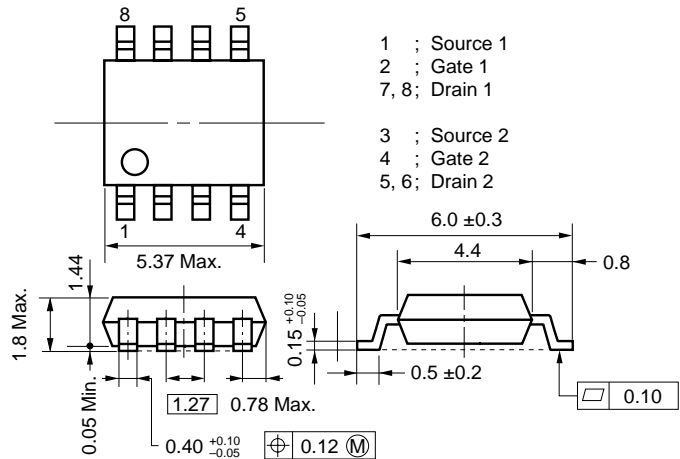
DESCRIPTION

This product is Dual N-channel MOS Field Effect Transistor designed for Li-ion battery applications and power management applications of notebook computers.

FEATURES

- Dual chip type
- Low on-resistance
 $R_{DS(on)1} = 32 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 3.5 \text{ A)}$
 $R_{DS(on)2} = 53 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4 \text{ V, } I_D = 3.5 \text{ A)}$
- Low input capacitance $C_{iss} = 780 \text{ pF TYP.}$
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

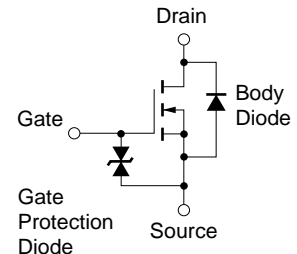
PACKAGE DRAWING (Unit : mm)



ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1754G	Power SOP8

EQUIVALENT CIRCUIT
(1/2 Circuit)



ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, All terminals are connected.)

Drain to Source Voltage (V _{GS} = 0)	V _{DSS}	30	V
Gate to Source Voltage (V _{DS} = 0)	V _{GSS}	±20	V
Drain Current (DC)	I _{D(DC)}	±7.0	A
Drain Current (pulse) ^{Note1}	I _{D(pulse)}	±28	A
Total Power Dissipation (1 unit) ^{Note2}	P _T	1.7	W
Total Power Dissipation (2 unit) ^{Note2}	P _T	2.0	W
Channel Temperature	T _{ch}	150	°C
Storage Temperature	T _{stg}	-55 to + 150	°C

- Notes**
1. PW ≤ 10 μs, Duty cycle ≤ 1 %
 2. Mounted on ceramic substrate of 2000 mm² x 1.1 mm

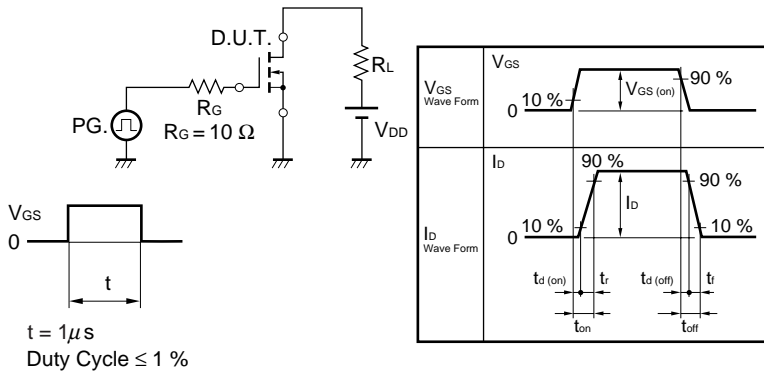
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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 Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

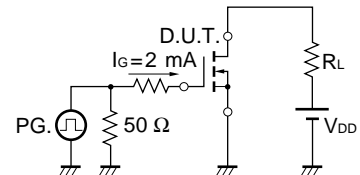
ELECTRICAL CHARACTERISTICS (T_A = 25 °C, All terminals are connected.)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	R _{DS(on)1}	V _{GS} = 10 V, I _D = 3.5 A		20	32	mΩ
	R _{DS(on)2}	V _{GS} = 4 V, I _D = 3.5 A		29	53	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.6	2.0	V
Forward Transfer Admittance	y _{fs}	V _{DS} = 10 V, I _D = 3.5 A	5.0	9.4		S
Drain Leakage Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0			10	μA
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0			±10	μA
Input Capacitance	C _{iss}	V _{DS} = 10 V		780		pF
Output Capacitance	C _{oss}	V _{GS} = 0		310		pF
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		110		pF
Turn-on Delay Time	t _{d(on)}	I _D = 3.5 A		7		ns
Rise Time	t _r	V _{GS(on)} = 10 V		103		ns
Turn-off Delay Time	t _{d(off)}	V _{DD} = 15 V		103		ns
Fall Time	t _f	R _G = 10 Ω		86		ns
Total Gate Charge	Q _G	I _D = 7.0 A		17.9		nC
Gate to Source Charge	Q _{GS}	V _{DD} = 24 V		2.3		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = 10 V		4.3		nC
Body Diode forward Voltage	V _{F(S-D)}	I _F = 7.0 A, V _{GS} = 0		0.80		V
Reverse Recovery Time	t _{rr}	I _F = 7.0 A, V _{GS} = 0		29		ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100 A/μs		44		nC

TEST CIRCUIT 1 SWITCHING TIME

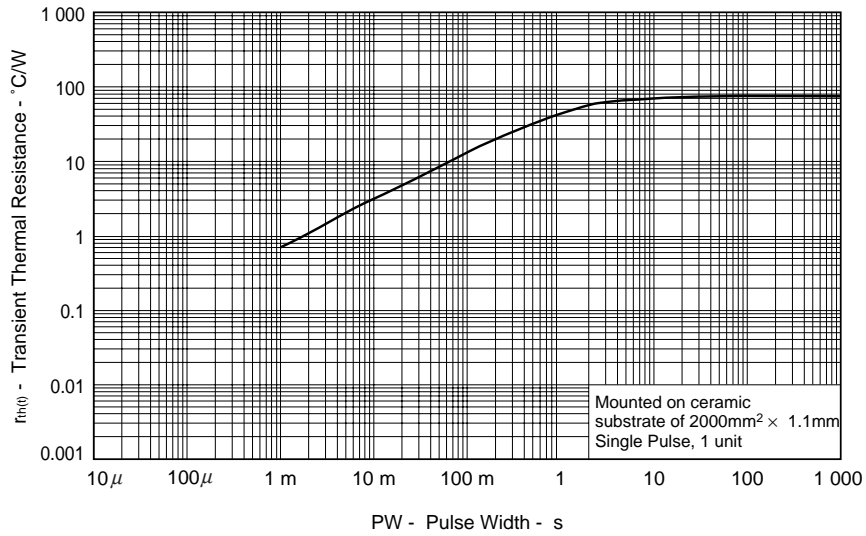


TEST CIRCUIT 2 GATE CHARGE

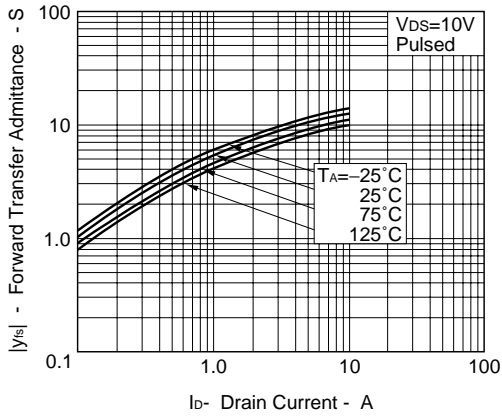


TYPICAL CHARACTERISTICS (T_A = 25 °C)

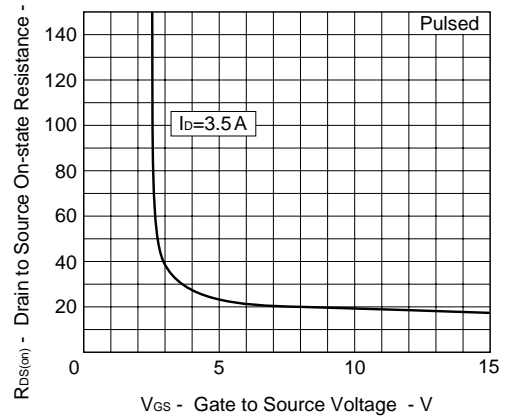
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



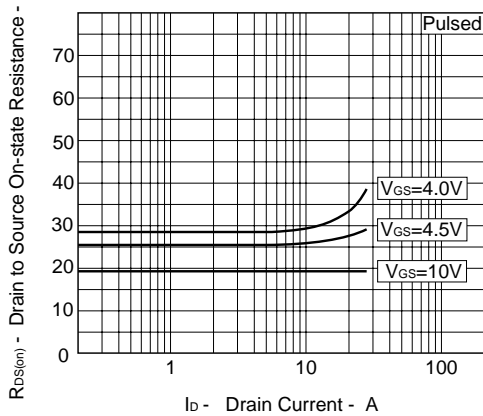
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



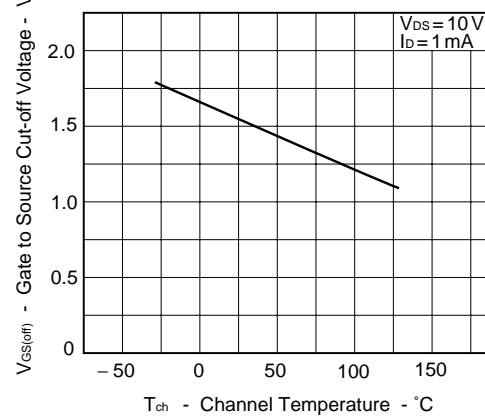
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

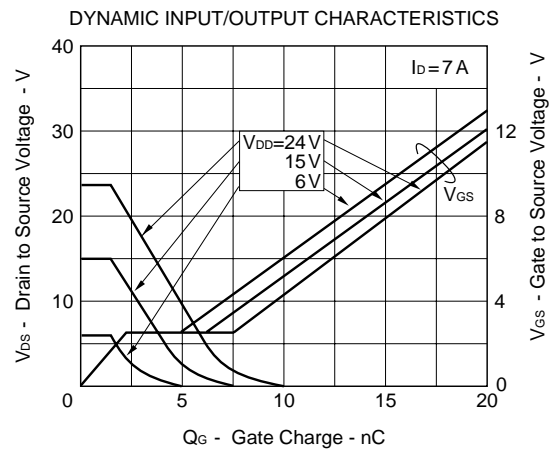
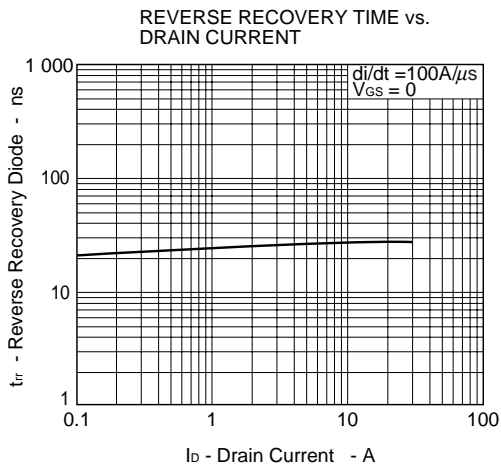
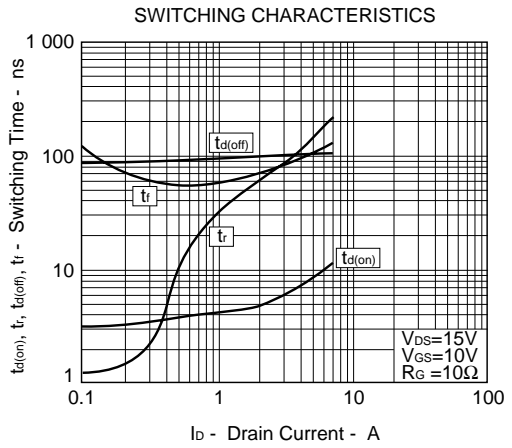
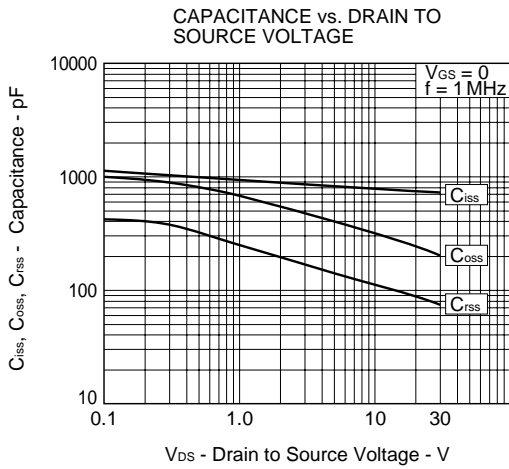
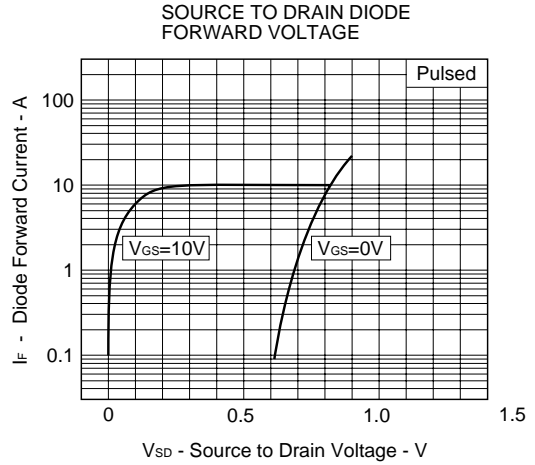
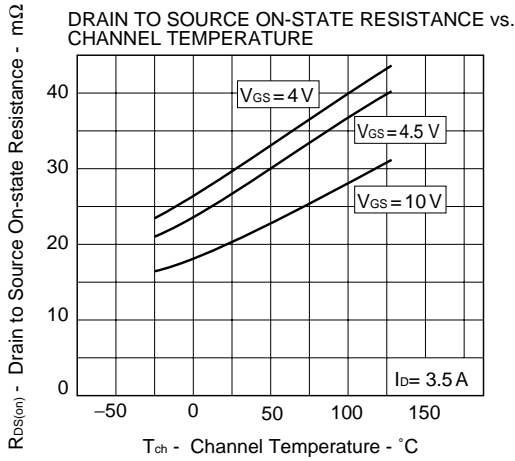


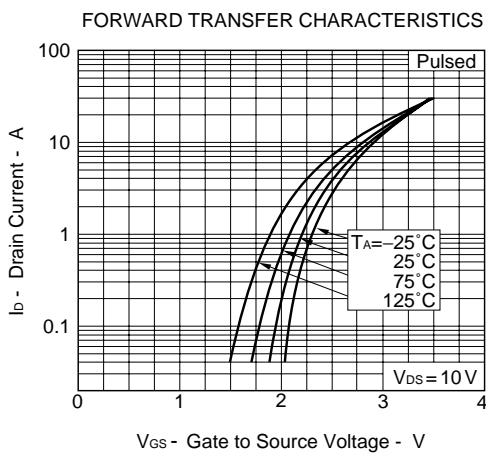
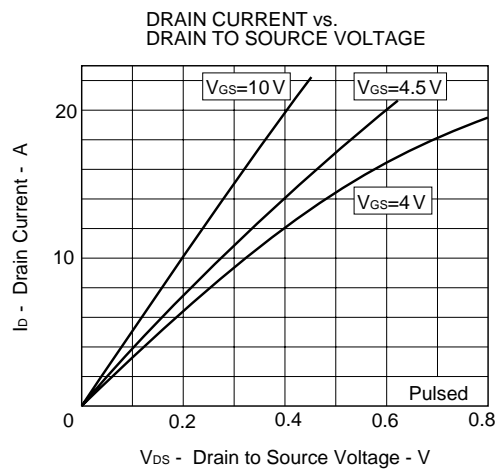
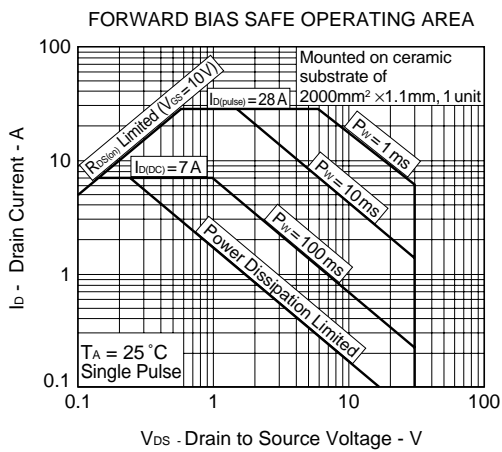
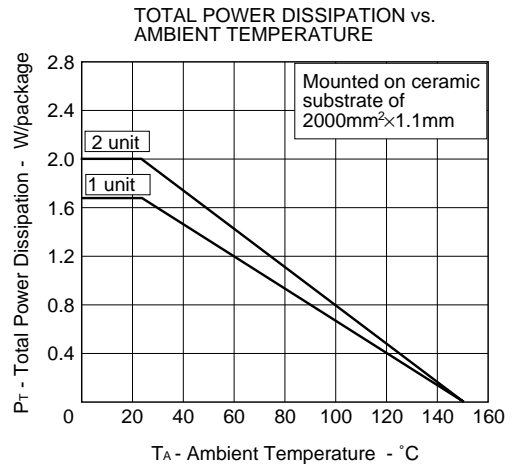
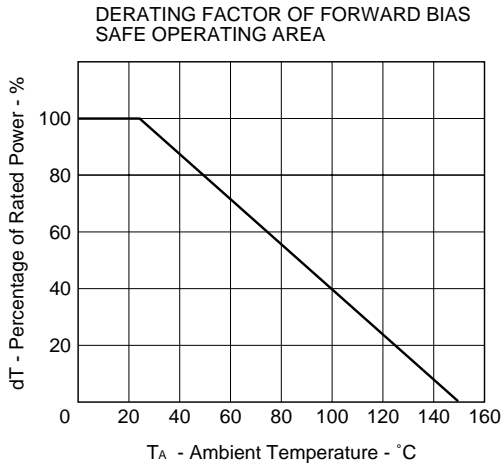
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE







[MEMO]

[MEMO]

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